## Notice of References Cited Application/Control No. 10/622,692 Examiner John S. Chu Applicant(s)/Patent Under Reexamination AKITA ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0224290 A1	12-2003	Kobayashi et al.	430/270.1
*	В	US-2003/0207201 A1	11-2003	Hatakeyama et al.	430/270.1
*	С	US-6,692,884 B2	02-2004	Fujimori et al.	430/170
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			*
	J	US-			
	К	US-			
	L	US-			
	М	US-			·

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	<b>V</b>	
9	W	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.